

<b>Notice of References Cited</b>	Application/Control No. 10/825,414	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner James A. Dudek	Art Unit 2871	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0099580 A1	05-2005	Lee et al.	349/156
	B	US-5,828,434 A	10-1998	Koden et al.	349/148
	C	US-5,880,803 A	03-1999	Tamai et al.	349/156
	D	US-5,793,457	08-1998	Tamai et al.	349/110
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.